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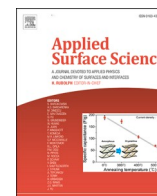
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## Full Length Article

High-performance type II WSO<sub>x</sub>/WS<sub>2</sub>-based heterojunction photodetectors

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## ABSTRACT

Van der Waals heterojunctions (vdWHs) have garnered significant attention for their promising applications in optoelectronics, attributed to their exceptional physical attributes. In this study, we present a straightforward approach to fabricating high-performance vdWHs photodetectors. Specifically, we prepared WSO<sub>x</sub>/WS<sub>2</sub> vdWH photodetectors through the ozone oxidation of a WS<sub>2</sub> thin films at 100 °C. To characterize the morphology and optical properties of both the WS<sub>2</sub> and WSO<sub>x</sub>/WS<sub>2</sub> thin films, we utilized atomic force microscopy (AFM) and Raman spectroscopy. Additionally, X-ray photoelectron spectroscopy (XPS) was employed to delve into the structural evolution by scrutinizing the bonding states of W, O, and S in the WS<sub>2</sub> before and after the ozone oxidation process. The resultant WSO<sub>x</sub>/WS<sub>2</sub> vdWH photodetectors exhibited impressive photoelectric performance at wavelengths of 475 nm and 532 nm. It demonstrated a high responsivity of 230.7 A/W, a remarkable specific detectivity of  $1.794 \times 10^{11}$  Jones, and a swift response speed of 60 ms at 475 nm. Furthermore, first-principles calculations based on density functional theory (DFT) were conducted to validate the oxidation kinetics of monolayer WS<sub>2</sub>, the type II energy band alignment, and the interlayer charge transfer within the WSO<sub>x</sub>/WS<sub>2</sub> vdWH. This research contributes novel insights into the synthesis of two-dimensional transition metal oxides (TMOs)-transition metal dichalcogenides (TMDCs) heterostructures for photodetector applications.

## 1. Introduction

Two-dimensional (2D) materials have garnered significant attention owing to their exceptional optoelectronic characteristics. In comparison to traditional semiconductor materials, 2D-based photodetectors exhibit a broad spectral response, remarkable stability, and substantial advantages in optoelectronic detection. These advantages stem from their tunable band gap ranging from 0 to 3 eV and their compact atomic and interlayer structure [1–5]. The advent of 2D transition metal dichalcogenides (TMDCs) has sparked immense research enthusiasm in the fields of nanoelectronics and optoelectronics. Characterized by unique physical attributes such as robust light-matter interactions, dangling-bond-free surfaces, and superior carrier mobility, 2D TMDCs serve as a versatile foundation for constructing heterojunctions. Leveraging the weak interlayer van der Waals forces, heterojunctions can be fabricated through layer-by-layer stacking of diverse 2D materials, regardless of their individual properties. This capability facilitates a diverse array of

applications in optoelectronic devices, notably including photodetectors [6–12].

Atomic-thickness tungsten disulfide (WS<sub>2</sub>), a member of the 2D TMDCs family, has garnered considerable attention for its application in photovoltaic devices such as photodetectors and photovoltaic cells. This is attributed to their high carrier mobility, exceptional thermal and chemical stability, and thickness-dependent bandgap, which have been extensively studied in literature [13–16]. The integration of WS<sub>2</sub> with various other 2D materials to form heterostructures opens up a broader horizon for the design and development of high-performance optoelectronic devices compared to using single WS<sub>2</sub> materials alone. Heterostructures provide a multitude of benefits, including enhanced functionality, a tunable band structure, improved carrier separation efficiency, and augmented light absorption capabilities [17,18]. These distinctive advantages position WS<sub>2</sub>-based van der Waals heterojunctions (vdWHs) as promising candidates for optoelectronic detection applications and provide fertile ground for innovating and advancing

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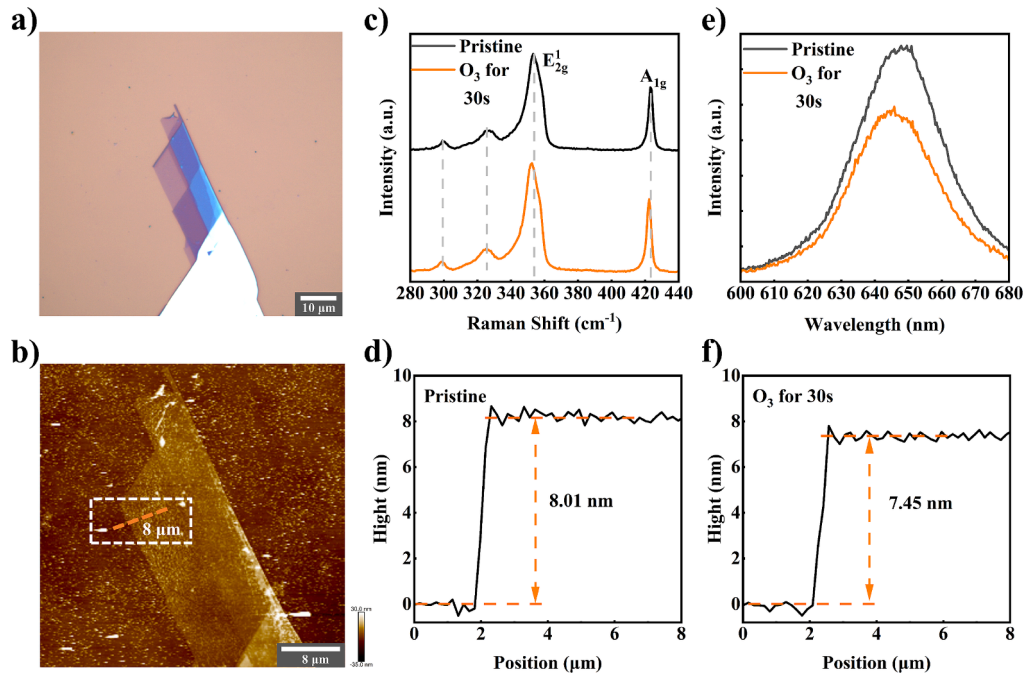
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**Fig. 1.** a) Optical image of WS<sub>2</sub> film used for before and after-oxidation characterisation. b) AFM image of WS<sub>2</sub> thin films. c) Raman spectra of WS<sub>2</sub> and WSO<sub>x</sub>/WS<sub>2</sub>. d) WS<sub>2</sub> film thickness. e) PL spectra of WS<sub>2</sub> and WSO<sub>x</sub>/WS<sub>2</sub>. f) WSO<sub>x</sub> film thickness.

high-performance optoelectronic devices.

To date, various WS<sub>2</sub>-based 2D vdWHs have been fabricated for photodetector applications, encompassing combinations like WS<sub>2</sub>/Bi<sub>2</sub>Se<sub>3</sub> [19], FePS<sub>3</sub>/WS<sub>2</sub> [20], and WS<sub>2</sub>/GaAs [21], etc. Nonetheless, their use in devices also presents challenges due to their increased susceptibility to oxidation under ambient conditions [22]. In recent findings, Borah et al. leveraged oxidized WSe<sub>2</sub> to enhance the electrical properties of field-effect transistors (FETs) [23]. Similarly, Ngo et al. exhibited a technique for locally oxidizing WSe<sub>2</sub> FETs, yielding high-performance 2D p-type WSe<sub>2</sub> FETs [24]. Despite these advancements, the impact of oxidation on the optoelectronic performance of WS<sub>2</sub>-based devices remains unexplored. Consequently, it is imperative to undertake a thorough examination of the oxidation mechanism of WS<sub>2</sub> and explore the preparation of 2D TMDCs heterojunction optoelectronic devices through controlled oxidation processes.

In this study, we report the fabrication of WSO<sub>x</sub>/WS<sub>2</sub> heterojunction devices by transferring mechanically exfoliated WS<sub>2</sub> films onto SiO<sub>2</sub>/Si substrates, followed by subsequent oxidation using ozone. These heterojunction devices exhibit exceptional photoresponse characteristics and robust stability. Notably, they demonstrate high responsivity ( $R_{\lambda}$ ) values reaching 230.7 AW<sup>-1</sup> and specific detectivity ( $D^*$ ) values as high as  $1.794 \times 10^{11}$  Jones. To gain deeper insights, we conducted first-principles calculations to investigate the electronic properties of both WS<sub>2</sub> and WSO<sub>x</sub>/WS<sub>2</sub>, including their adsorption and binding energies. Our findings reveal that the WSO<sub>x</sub>/WS<sub>2</sub> heterojunction possesses a type-II band alignment, which is advantageous for enhancing photoelectric conversion efficiency, improving light absorption and emission performance, and promoting the effective separation of electrons and holes. Furthermore, we delved into the kinetics of WS<sub>2</sub> oxidation, aiming to provide a comprehensive mechanistic understanding and establish a foundational basis for the preparation of heterojunctions through controlled oxidation. Importantly, the devices demonstrate the capability for weak light detection at room temperature. The preparation method employed here is not only straightforward and controllable but also versatile, accommodating a wide range of TMDCs' oxidation.

## 2. Calculation method

All calculations in the CASTEP and Dmol3 modules are performed using first-principles density functional theory and Perdew Burke-Ernzerhof (PBE) pseudopotentials [25–27]. The Generalised Gradient Approximation (GGA) of the PBE was used for geometry optimization and energy band calculations with the truncation energy set to 450 eV [28,29]. The Monkhorst-Pack method was used to select a  $12 \times 12 \times 1$  k-point grid in the Brillouin zone [30]. The thickness of the vacuum layer is set to 15 Å along the Z-axis to eliminate the interaction of periodic boundaries [31]. The results of vdW force interactions induced by weak interlayer coupling were corrected using the DFT-D3 method of Grimme [32]. The maximum displacement of each atom during structural relaxation was set to 0.2 μm, and the convergence threshold of the atoms was set to 0.2 μm. Energies and interatomic forces of  $1 \times 10^{-5}$  eV and 0.01 eV<sup>-1</sup> were used for subsequent calculations of electronic properties. Calculations were performed with the Dmol3 code using the linear simultaneous and quadratic (LST/QST) method. Transition states and potential energies for O<sub>3</sub> dissociation and O atom substitution reactions were calculated using the LST/QST method, and transition states (TS) were obtained using the generalized LST/QST proposed by Govind from the original method of Halgren and Lipscomb [33,34].

## 3. Experimental section

### 3.1. Fabrication of WSO<sub>x</sub>/WS<sub>2</sub> heterojunction devices

Thin WS<sub>2</sub> flakes were peeled from the bulk crystals by mechanical stripping using transparent adhesive tapes, and then the peeled WS<sub>2</sub> films were transferred to electrodes on SiO<sub>2</sub>/Si substrates with pre-deposited electrodes (Ti/Au) using a PDMS-assisted dry transfer technique. The transferred films were then oxidized into an ozone environment at 100°C for 30 s and WSO<sub>x</sub> was formed on the top layer of WS<sub>2</sub> to complete the preparation of WSO<sub>x</sub>/WS<sub>2</sub> heterojunction devices. A small ozone generator provides ozone and maintains the ozone concentration in 0.0187 mg/L. Before transferring, the Si substrate was cleaned sequentially with ethanol and deionized water.

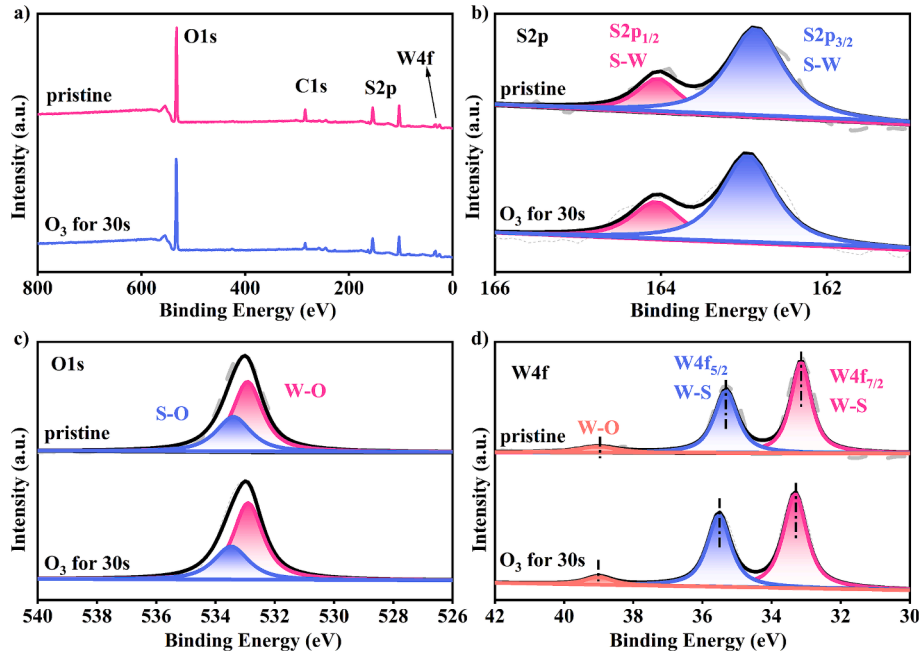


Fig. 2. XPS spectra for  $WS_2$  and  $WSO_x/WS_2$ . a) Full – range XPS spectra, b) S 2p spectra, c) O 1 s spectra, and d) W 4f spectra.

### 3.2. Characterization

$WS_2$  films were imaged by a Keyence VHX-600 optical microscope. Raman spectra were obtained by confocal Raman microscopy system WITec alpha 300R (WITecInc., Germany) at room temperature (300 K) using 532 nm excitation. Morphological characterization was carried out using Bruker's Dimension Icon AFM model to measure the thickness of  $WS_2$  before and after  $O_3$  treatment, and the surface morphology and roughness of the samples were analyzed using Nanoscope Analysis software to obtain the thickness of the test samples. Chemical compositions and element ratios were examined using X-ray photoelectron spectroscopy (XPS; Thermo Scientific K-Alpha +). We conducted all I-V curve measurements in a probe station using a digital source meter (Keithley 2636). To provide illumination, a 150 W-Xe lamp (Zolix Gloria-X150A) served as the light source, while a monochromator (Zolix omni-30471) enabled the selection of specific wavelengths and spectral

scanning. Light-path on/off was managed by a mechanical shutter controlled through a repeated transistor-transistor logic (TTL) signal. For calibration purposes, we utilized the opto-electrical response of a standard Si detector (Hamamatsu, QE-B3-UV) as a reference.

### 4. Results and discussions

The  $WS_2$  thin film and  $WSO_x/WS_2$  heterojunction are characterized by means of AFM, optical spectroscopy techniques and XPS. Fig. 1a illustrates the structure diagram of the  $WS_2$  thin film on  $SiO_2/Si$  substrate. The  $WSO_x/WS_2$  heterojunction is prepared by dry transferring of  $WS_2$  thin film with subsequent ozone oxidation method as has described in the experiment. AFM image for characterizing the morphology and structure of the  $WS_2$  thin film and  $WSO_x/WS_2$  heterojunction is shown in Fig. 1b. Raman spectra are employed to further investigate the crystalline structures and qualities of the mechanically exfoliated  $WS_2$  and

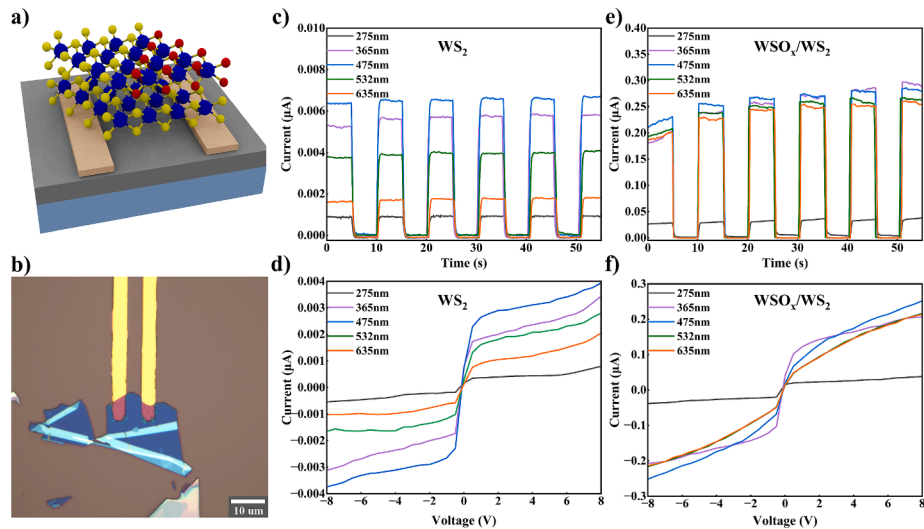


Fig. 3. a) Schematic of the heterojunction device. b) Optical image of the  $WSO_x/WS_2$  photodetector. c, d) I-t curves of pristine  $WS_2$  and  $WSO_x/WS_2$  photodetectors irradiated at  $V_{ds} = +5$  V and  $18.2 \mu W \cdot cm^{-2}$  power density of 275 nm, 365 nm, 475 nm, 532 nm and 635 nm lasers. e, f) I-V curves of pristine  $WS_2$  and  $WSO_x/WS_2$  photodetectors irradiated by lasers of different wavelengths.

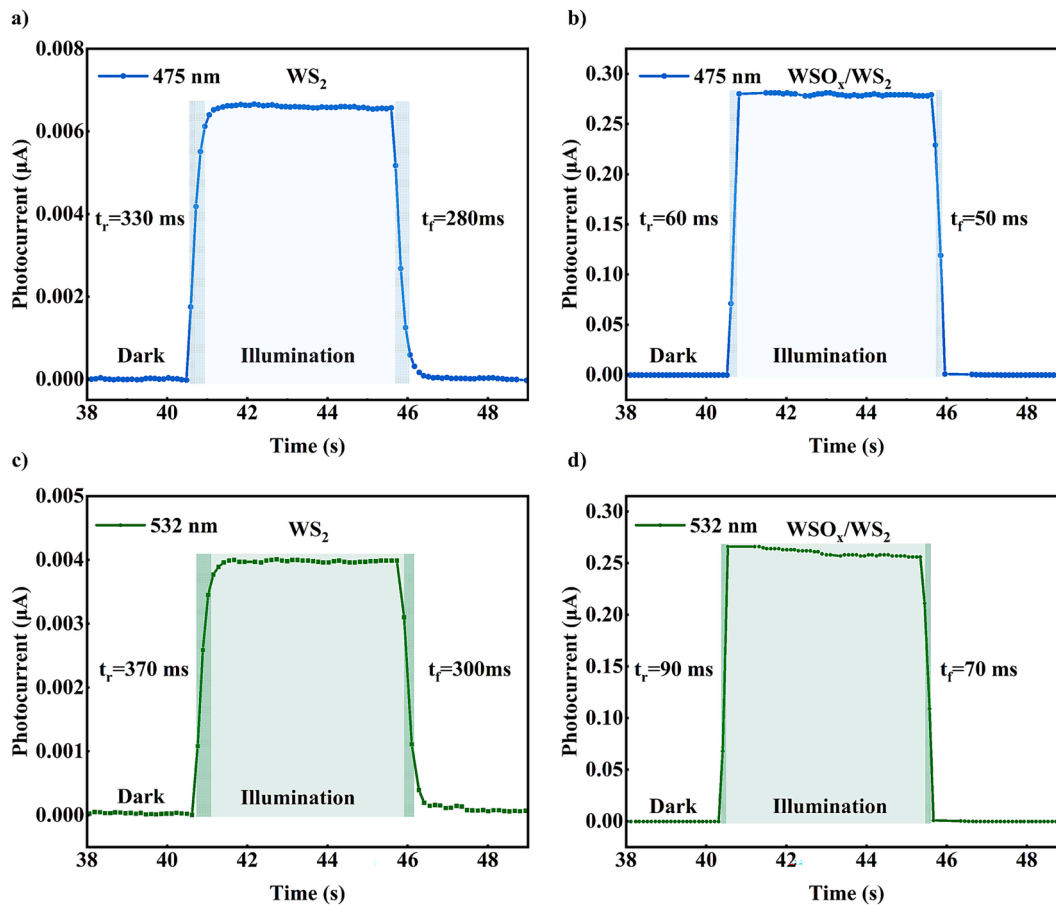


Fig. 4. Dynamic photoresponse of a)  $\text{WS}_2$  and b)  $\text{WSO}_x/\text{WS}_2$  devices under 475 nm light irradiation, Dynamic photoresponse of a)  $\text{WS}_2$  and b)  $\text{WSO}_x/\text{WS}_2$  devices under 532 nm light irradiation.

$\text{WSO}_x/\text{WS}_2$  heterojunction. Fig. 1c shows the Raman spectra of  $\text{WS}_2$  and  $\text{WSO}_x/\text{WS}_2$  heterojunction at room temperature with laser excitation at 532 nm. The observed Raman characteristic peaks of  $\text{WS}_2$  are located at 352.5 and 421.5  $\text{cm}^{-1}$  corresponding to the in-plane vibration  $E_{2g}^1$  mode and the out-of-plane  $A_{1g}$  mode, respectively [35]. Compared with  $\text{WS}_2$ , the peaks of the  $E_{2g}^1$  and  $A_{1g}$  of  $\text{WSO}_x/\text{WS}_2$  heterojunction have a relative blue-shift of  $\Delta\omega$  of 1.02 and 1.31  $\text{cm}^{-1}$ , respectively, while the remaining peaks are not shifted. The changes in vibrational modes indicate that there is a strong interlayer coupling between the  $\text{WS}_2$  and  $\text{WSO}_x/\text{WS}_2$  heterojunction. PL spectra of  $\text{WS}_2$  and  $\text{WSO}_x/\text{WS}_2$  heterostructure are shown in Fig. 1e. It indicates that the PL peak intensity of the  $\text{WSO}_x/\text{WS}_2$  heterojunction is weaker than that of  $\text{WS}_2$  significantly. This quenching phenomenon effectively proves the charge separation at the heterojunction, further verifies the interlayer coupling effect in the heterostructure, and indicates the photoexcited charge carriers undergo non-radiation recombination instead of PL emission [36]. It implies that an ultrafast photoexcited carrier transportation will occur at the interface of the heterostructure. In Fig. 1d and f, the thicknesses of  $\text{WS}_2$  and  $\text{WSO}_x/\text{WS}_2$  are 8.01 and 7.45 nm, respectively. The results show that O atoms substitution occurs in the top layer of the  $\text{WS}_2$  film by oxidation, which leads to a reduction in the thickness of the  $\text{WS}_2$  layer.

XPS was conducted to further confirm the elemental composition and bonding state of the  $\text{WSO}_x/\text{WS}_2$  heterostructure. In Fig. 2a, the XPS spectrum clearly shows W, S, and O elements after C1s spectrum calibration. The S 2p spectra of these composites were characterized in Fig. 2b. Fig. 2c shows that the O 1s spectra of the  $\text{WSO}_x/\text{WS}_2$  heterostructure can be well fitted into the peak at 530.40 eV. Fig. 2d displays the W4f spectra of  $\text{WS}_2$  and  $\text{WSO}_x/\text{WS}_2$ . The two peaks of W  $4f_{5/2}$  and W  $4f_{7/2}$  of  $\text{WS}_2$  are situated at about 33.24 eV and 35.4 eV. After oxidation,

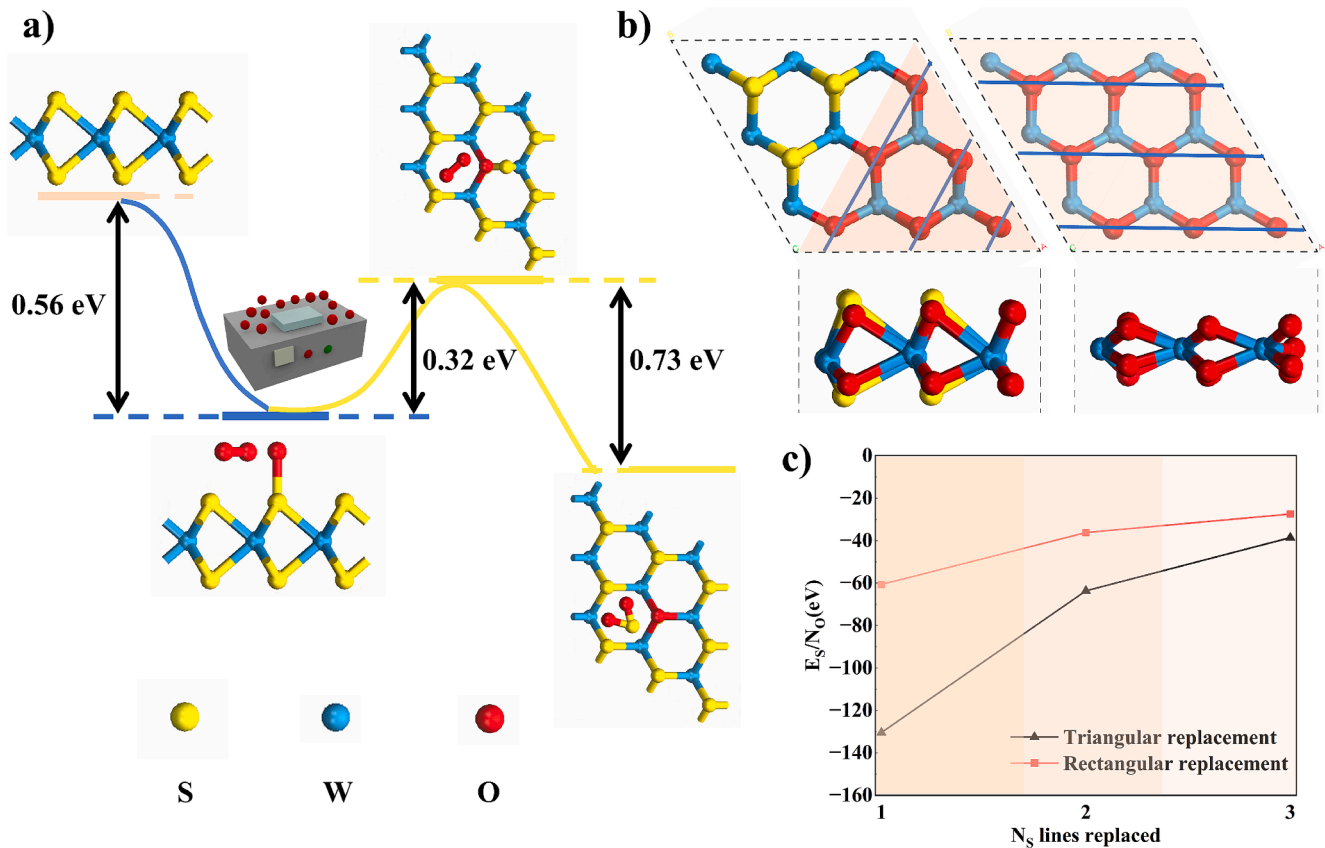
compared with  $\text{WS}_2$ , the peak of W  $4f_{5/2}$  and the W-O band of  $\text{WSO}_x/\text{WS}_2$  heterojunction exhibit displacement to higher energy, while the remaining peaks maintain their original position. It is conceivable that the O elements may be responsible for the transfer of electrons, thereby enabling W to attain a greater degree of binding energy, a result consistent with previous reports [37,38]. Summarily, all the XPS spectra results imply the  $\text{WS}_2$  thin film is oxidized and demonstrates a successful construction of  $\text{WSO}_x/\text{WS}_2$  heterostructure.

Fig. 3a illustrates the structure diagram of the  $\text{WSO}_x/\text{WS}_2$  vdWH photodetector constructed on  $\text{SiO}_2/\text{Si}$  substrate. The optical image of the device is shown in Fig. 3b. Fig. 3c-f present the switching behavior of the devices under periodic illumination with different wavelengths from UV to VIS (Ultraviolet to Visible light, including 275, 365, 475, 532 and 635 nm), with a power intensity of 18.2  $\mu\text{W}$  at  $V_{ds} = +5$  V. Compared with  $\text{WS}_2$  photodetector, the photoelectric response capability of  $\text{WSO}_x/\text{WS}_2$  heterojunction photodetector enhances about 45 times. Fig. 3e and d show the output characteristic curves ( $I_{ds}-V_{ds}$ ) of the devices with 275, 365, 475, 532 and 635 nm laser irradiations. The findings demonstrate that the higher photocurrent is generated by 475 nm laser irradiation of both  $\text{WS}_2$  and  $\text{WSO}_x/\text{WS}_2$  heterojunction photodetectors than that of other light wavelengths. Additionally, the photocurrent of  $\text{WSO}_x/\text{WS}_2$  is observed to be approximately 64 times higher than that of  $\text{WS}_2$ . In general, at all illumination wavelengths above, the  $\text{WSO}_x/\text{WS}_2$  heterojunction device yields a definite switching behavior and exhibits superior photoelectric performance than the  $\text{WS}_2$  device, demonstrating its feasibility for stable photodetection.

Response time describes the instantaneous response speed of the photodetector to the change of the input optical signal and records the transient photocurrent signal of the device. As illustrated in Fig. 4, we

**Table 1**  
Performance comparison of various photodetectors based on 2D TMDCs.

Devices	Wavelength [nm]	Response time [ $\tau_r/\tau_f$ ms]	Responsivity [ $\text{A W}^{-1}$ ]	$D^*$ [Jones]	Photocurrent $I_{ph}$ ( $\mu\text{A}$ )	Ref.
$\text{WO}_3$	382	530/530	1.002	–	18.05	[43]
$\text{GaSe/ReS}_2$	340 nm	261/274	170	–	20.71	[44]
$\text{WS}_2/\text{WO}_3$	382/512	100/100	2.94/2.02	$14.19/9.71 \times 10^{10}$	486.43/292.81	[45]
$\text{WS}_2$	458–647	5.3/5.3	$9.27 \times 10^{-5}$	$4.7 \times 10^5$	–	[46]
$\text{MoS}_2/\text{WS}_2$	532	80/60	$1.1 \times 10^{-3}$	$2.5 \times 10^6$	–	[47]
$\text{WSO}_x/\text{WS}_2$	475–635	70/60	230.7	$1.794 \times 10^{11}$	0.252	this work



**Fig. 5.** Reaction kinetics of the oxidized structure of  $\text{WS}_2$ . a) Reaction kinetics and transition states during oxidation. b) Triangular O-substituted structure of a  $3 \times 3$  monolayer  $\text{WS}_2$  supercell; Rectangular O-substituted structure of a  $3 \times 3$  monolayer  $\text{WS}_2$  supercell. c) Stability energies ( $E_s$ ) normalized to the number of substituting O atoms ( $N_0$ ) as a function of the number of S-lines with triangular (delta) and rectangular (square) substitutions. As a function of the number of O atoms substituted from spectral line 1 to spectral line 3.

have measured the photoswitching characteristics of both  $\text{WS}_2$  and  $\text{WSO}_x/\text{WS}_2$  devices at wavelengths of 475 nm and 532 nm, respectively. Specifically, the rise time and fall time are defined as the durations required for the photocurrent to transition from 10 % to 90 % and from 90 % to 10 % of the stable photocurrent value, respectively, serving as indicators of the device's sensitivity [39]. From the I-t curves of the devices, it is apparent that the  $\text{WSO}_x/\text{WS}_2$  heterojunction device demonstrates swift rise and fall times of 60 ms and 50 ms at 475 nm, and 90 ms and 70 ms at 532 nm. These times are more than an order of magnitude faster compared to the  $\text{WS}_2$  device under laser illumination at 475 nm.

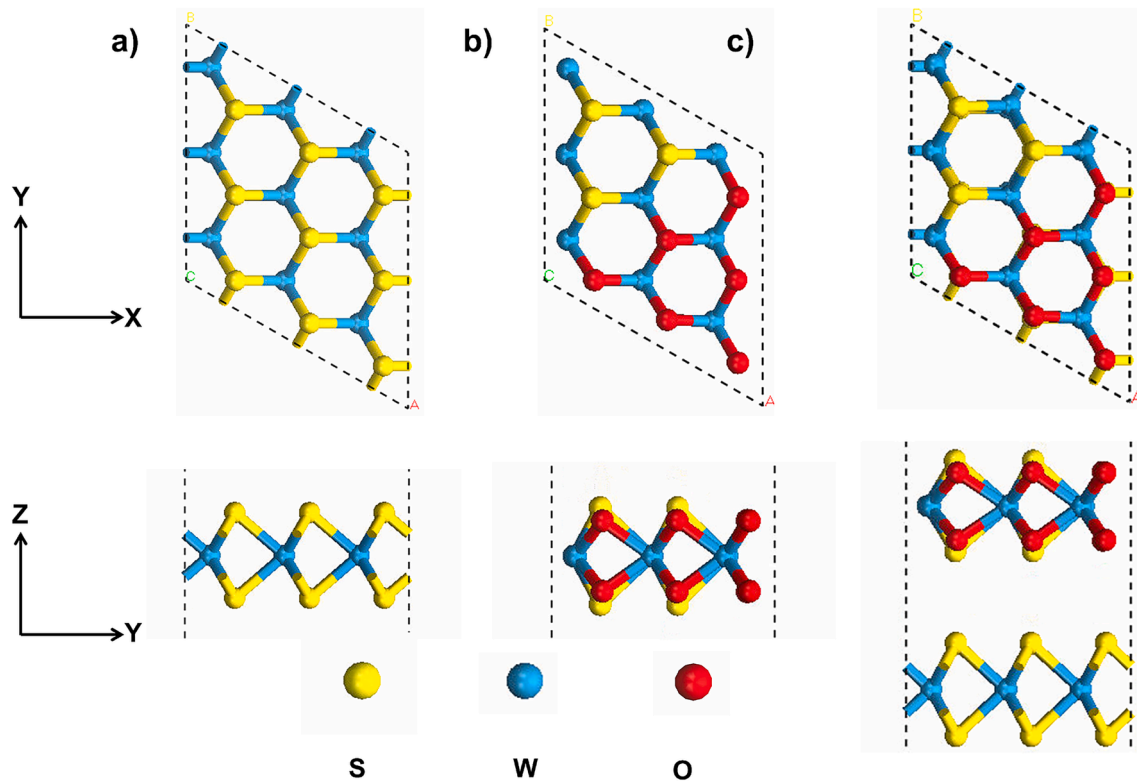
Furthermore, the key performance parameters of photoresponsivity ( $R_\lambda$ ) and specific detectivity ( $D^*$ ) are evaluated by the following equations [40,41]:

$$R_\lambda = \frac{(I_{photo} - I_{dark})}{P \cdot S} \quad (1)$$

$$D^* = \frac{R_\lambda \cdot \sqrt{S}}{\sqrt{2eI_{dark}}} \quad (2)$$

where  $I_{photo}$  and  $I_{dark}$  are the photocurrent and dark current, respectively,  $P$  is the laser power density,  $S$  is the effective area upon illumination ( $60 \mu\text{m}^2$ ),  $e$  is the electronic charge. In this work,  $R_\lambda$  and  $D^*$  at the illumination power density of  $18.2 \mu\text{W}/\text{mm}^{-2}$  are calculated to be  $230.7 \text{ A W}^{-1}$  and  $1.794 \times 10^{11}$  Jones, respectively. The  $R_\lambda$  can intuitively reflect the sensitivity of the devices [42]. Table 1 summarizes the important figures-of-merit of the previous reports. Generally, our device stands out considering the detectivity and response time.

To achieve a better understanding of oxidation mechanism of monolayer  $\text{WS}_2$ , the oxidation process of monolayer  $\text{WS}_2$  is studied by DFT calculation. The energy barriers and transition states during the oxidation of  $\text{WS}_2$  are investigated by first-principles calculations. Fig. 5a shows the formation of  $\text{O}_3$  dissociation, O atom adsorption to form S-O bonds, and O atom substitution during the reaction of  $\text{O}_3$  with  $\text{WS}_2$ . To



**Fig. 6.** Top and side views of the optimized structure. a) 3x3 monolayer WS<sub>2</sub> supercell. b) Top and side views of 3x3 monolayer WSO<sub>x</sub> supercell. c) Top and side views of WSO<sub>x</sub>/WS<sub>2</sub> heterostructure.

determine the energies of the transition states and to find the energy barriers for the oxidation substitution process, we used the calculation method of the Climbing Image Nudge Elastic Band (CI-NEB) model [34]. The results show that the energy barrier of our proposed reaction pathway is 0.32 eV after the adsorption reaction with oxygen atoms on the surface of WS<sub>2</sub> crystals, and the energy enthalpy of this reaction changes to  $-0.41$  eV, which implies that the substitution of oxygen atoms by sulfur atoms after the dissociation of O<sub>3</sub> molecules is thermodynamically favorable.

In addition, we investigated the adsorption energy of ozone with the monolayer WS<sub>2</sub> surface, and the equation for the enthalpy change of adsorption energy was defined as:

$$E_{(adsorption)} = E_{(WS_2)} + E_{(O_3)} - E_{(WS_2+O_3)} = -0.49eV \quad (3)$$

Calculations show that the reaction of ozone adsorption on a monolayer WS<sub>2</sub> surface is also thermodynamically favorable [48–50]. To determine the oxidation structure of WS<sub>2</sub>, as shown in Fig. 5b, the O atom spectral lines were used to gradually replace the S atom spectral lines, forming triangular and rectangular structures, respectively. The stability energies of the oxidation structure of WS<sub>2</sub> are defined as:

$$E_S = E_{Total} - \sum_i N_i E_i \quad (4)$$

where  $E_S$  is the stabilization energy and  $E_{Total}$  is the total energy of the system, obtained from the Dmol3 calculation module.  $N_i$  and  $E_i$  are the number and energy of individual atoms of species  $i$  ( $i = W, S, O$ ), respectively [51,52]. The results in Fig. 5c show that the stability of the structure substituted with triangular oxide islands is higher than that of the structure with rectangular oxide islands. Therefore, we determined the structure of WS<sub>2</sub> oxidation by calculating the stability energy, and this result is consistent with the oxidation structures of other TMDCs materials [53,54].

For further investigating the electronic properties of WSO<sub>x</sub>/WS<sub>2</sub> vdWH the band structure, and partial-wave density of states (PDOS) of

**Table 2**  
Specific parameters of WS<sub>2</sub>, WSO<sub>x</sub>, and the WSO<sub>x</sub>/WS<sub>2</sub> heterojunction.

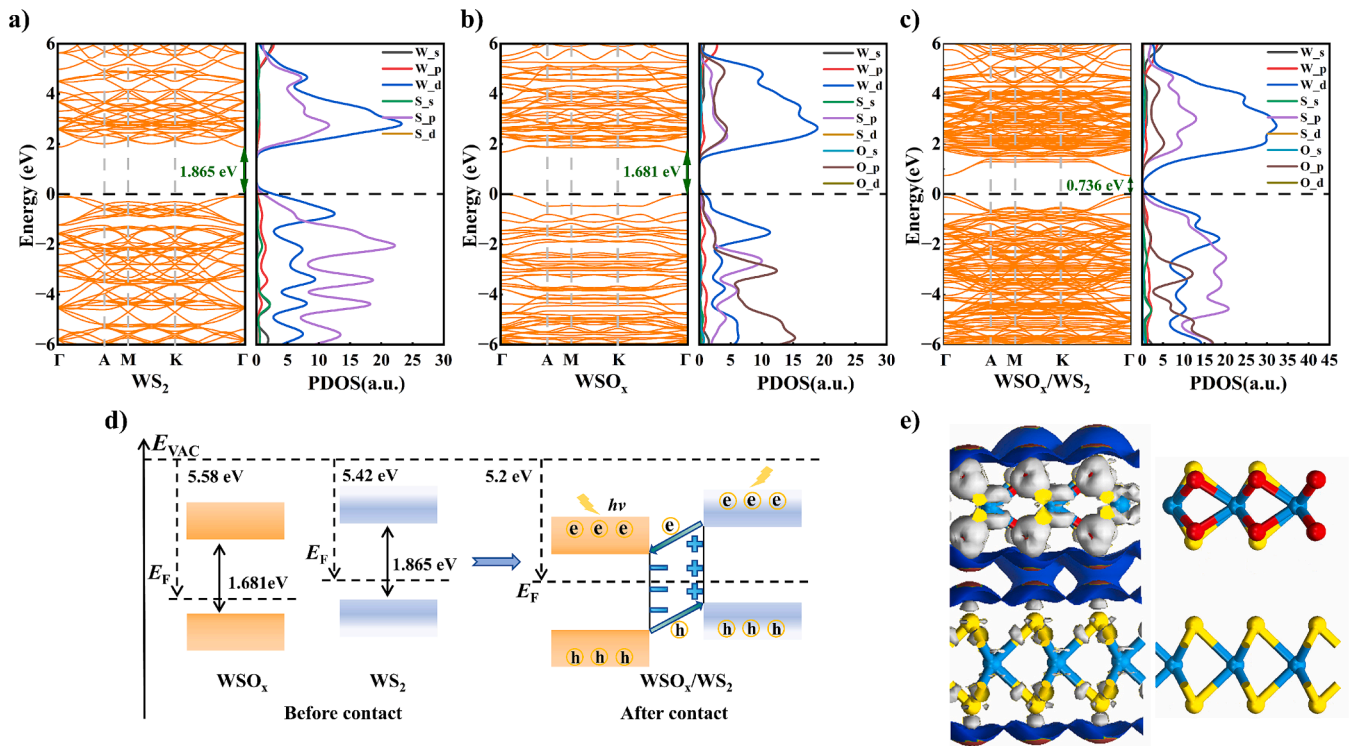
System	$L_{W-S}(\text{\AA})$	$L_{W-O}(\text{\AA})$	$d(\text{\AA})$	$E_b(\text{eV})$
WS <sub>2</sub>	2.416			
WSO <sub>x</sub>	2.416	2.037		
WSO <sub>x</sub> /WS <sub>2</sub>	2.443	2.068	3.255	$-5.133$

WSO<sub>x</sub>/WS<sub>2</sub> vdWH, monolayer WSO<sub>x</sub> and monolayer WS<sub>2</sub> were computed by PBE method. The lattice parameters of the WSO<sub>x</sub> monolayer and WS<sub>2</sub> monolayer are 3.76 Å and 3.52 Å, respectively. The monolayer WSO<sub>x</sub> and monolayer WS<sub>2</sub> were expanded by  $3 \times 3 \times 1$ , respectively, and the optimized WSO<sub>x</sub> was vertically stacked on top of the optimized WS<sub>2</sub> to construct a vdWH. Fig. 6a-c depict the top and side views of the optimized WS<sub>2</sub> monolayer, WSO<sub>x</sub> monolayer, and WSO<sub>x</sub>/WS<sub>2</sub> vdWH, respectively. To investigate the stability of the WSO<sub>x</sub>/WS<sub>2</sub> vdWH structure, the binding energy ( $E_b$ ) of the WSO<sub>x</sub>/WS<sub>2</sub> vdWH was calculated. The calculation formula is given below:

$$E_b = E_{WSO_x/WS_2} - E_{WSO_x} - E_{WS_2} \quad (5)$$

where  $E_{WSO_x/WS_2}$  is the energy of the WSO<sub>x</sub>/WS<sub>2</sub> vdWH,  $E_{WSO_x}$  is the energy of the monolayer WSO<sub>x</sub>, and  $E_{WS_2}$  is the energy of the monolayer WS<sub>2</sub>. The smaller the  $E_b$  (the larger the negative value), the more stable the structure [55]. The calculated  $E_b$  of the WSO<sub>x</sub>/WS<sub>2</sub> vdWH is  $-5.133$  eV, thus, the WSO<sub>x</sub>/WS<sub>2</sub> vdWH of the above configuration is a stable structure, and the specific parameters of the WSO<sub>x</sub>/WS<sub>2</sub> vdWH are shown in Table 2.

As demonstrated in Fig. 7a monolayer WS<sub>2</sub> has a direct band gap with 1.865 eV, both the valence-band maximum (VBM) and the conduction band minimum (CBM) located at  $\Gamma$ . From the PDOS diagram of the WS<sub>2</sub> monolayer, it can be perceived that CBM is chiefly rendered over  $d$  and  $p$  orbitals of the W. VBM is chiefly afforded via  $p$  orbitals of



**Fig. 7.** a) Energy band structure and PDOS plots of monolayer  $WS_2$  supercells. b) Energy band structure and PDOS plots of monolayer  $WSO_x$  supercells. c) Energy band structure and PDOS plots of  $WSO_x/WS_2$  heterojunction supercells. d) Alignment of type II energy bands of  $WSO_x/WS_2$  heterostructures. e) Difference in charge densities of  $WSO_x/WS_2$  heterostructures.

the S. As showcased in Fig. 7b monolayer  $WSO_x$  has a direct band gap with 1.681 eV. CBM is basically afforded over  $d$  orbital of W, while VBM is chiefly rendered via  $d$  and  $p$  orbitals of O. As showcased in Fig. 7c  $WSO_x/WS_2$  vdWH has a direct band gap of 0.736 eV, which is much smaller than two monolayers, and more favourable for the excitation of photogenerated electrons.

As a key parameter, the work function is calculated as follows:

$$W = E_{VAC} - E_F \quad (6)$$

where  $E_{VAC}$  represents the energy level of stationary electrons in vacuum and  $E_F$  represents the Fermi level [56]. The calculated work functions of the  $WSO_x$  and  $WS_2$  monolayers are 5.58 eV and 5.42 eV, separately. The work function of the  $WSO_x/WS_2$  vdWH is 5.2 eV. As shown in Fig. 7d, the band alignment of  $WSO_x$  monolayer,  $WS_2$  monolayer, and  $WSO_x/WS_2$  vdWH. Since the Fermi energy ( $E_F$ ) of the  $WSO_x$  layer is smaller than that of the  $WS_2$  layer, when the two layers contact, electrons will run from the conduction band of the  $WS_2$  to the conduction band of the  $WSO_x$ , and holes will run from the valence band of the  $WSO_x$  to the valence band of the  $WS_2$  [57]. When carriers diffuse, the  $E_F$  of  $WS_2$  decreases, while the  $E_F$  of  $WSO_x$  rises eventually reaching equilibrium.

As an important model to study the properties of atoms and molecules and its interactions [58], the charge density difference can be used to gain a better understanding of charge transfer in heterostructures at the interface using the form  $\Delta\rho = \rho_{WSO_x/WS_2} - \rho_{WSO_x} - \rho_{WS_2}$ , where  $\rho_{WSO_x/WS_2}$ ,  $\rho_{WSO_x}$ , and  $\rho_{WS_2}$  represent the charge densities of the heterostructure,  $WSO_x$ , and  $WS_2$  structures, respectively. Fig. 7e illustrates the differential charge density of  $WSO_x/WS_2$  heterostructures. We can find that there is charge accumulation at the interface area of  $WSO_x$  and  $WS_2$ . The blue isosurface represents the negative charge accumulation region and yellow represents the positive charge depletion region, respectively. Combining the analysis of the differential charge density and band structure, we find that  $WSO_x$  has a moderating effect on the electronic structure of  $WS_2$  and facilitating the generation and separation of electron-hole pairs [59,60]. Consequently, the  $WSO_x/WS_2$  vdWH

device has a faster response as well as a higher responsivity than that of  $WS_2$  device.

## 5. Conclusions

In conclusion, we introduce a straightforward method for synthesizing  $WSO_x/WS_2$  vertical vdWHs by oxidizing the top layer of  $WS_2$  to form a  $WSO_x$  layer through  $O_3$  oxidation at an ambient temperature of 100 °C. The thickness and structure of the heterojunction are characterized using AFM, Raman and PL spectroscopy, and XPS, respectively. The results confirm the successful synthesis of  $WSO_x/WS_2$  heterojunctions. Compared to the  $WS_2$  device, the  $WSO_x/WS_2$  vdWH device exhibits superior photoelectric performance, including a high responsivity of 230.7 A/W, and a promising and reliable detectivity of  $1.794 \times 10^{11}$  Jones, a higher photocurrent of 0.252  $\mu$ A, and a faster photoelectric response time of approximately 60 ms at 475 nm. Regarding the mechanism analysis, we present the thermodynamic energy barriers, transition states, and oxidation structure of monolayer  $WS_2$  during the oxidation process through DFT calculations. It is found that the heterojunction forms a type II energy band structure, which facilitates the effective separation of photogenerated electron-hole pairs. This, in turn, enhances the photocurrent and responsivity of the  $WSO_x/WS_2$  heterojunction devices. Notably, the devices are capable of detecting weak light at room temperature. More importantly, the preparation method is straightforward and controllable, accommodating a wide range of TMDs' oxidation. This study provides a viable route and theoretical foundation for the synthesis of transition-metal oxides (TMOs)-TMDs heterostructures for applications in photodetectors.

## CRediT authorship contribution statement

**Weiqi shi:** Writing – original draft, Visualization, Software, Methodology, Formal analysis, Data curation, Conceptualization. **Yifang Ding:** Validation, Investigation. **Shaojun Fang:** Investigation, Data

curation. **Hong Zhou:** Visualization, Validation, Methodology. **Jiao Qi:** Methodology, Investigation, Formal analysis. **Jiajie Fan:** Supervision, Writing – review & editing. **Rongjun Zhang:** Writing – review & editing, Supervision, Conceptualization. **Guoqi Zhang:** Visualization, Supervision. **Hongyu Tang:** Writing – review & editing, Supervision, Investigation, Funding acquisition, Conceptualization.

### Declaration of competing interest

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

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### Data availability

Data will be made available on request.

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